



**Alfa-MOS  
Technology**

**AFN3316W  
60V N-Channel  
Enhancement Mode MOSFET**

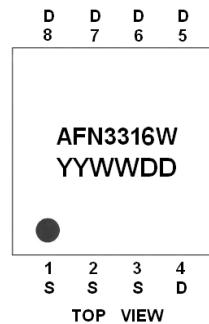
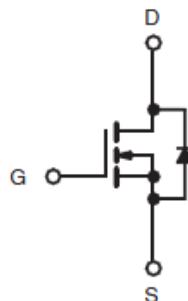
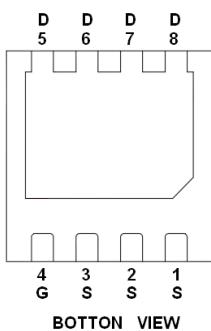
## General Description

AFN3316W, N-Channel enhancement mode MOSFET, uses Advanced Trench Technology to provide excellent  $R_{DS(ON)}$ , low gate charge. These devices are particularly suited for low voltage power management, and low in-line power loss are needed in commercial industrial surface mount applications.

## Features

- $I_D=8A, R_{DS(ON)}=140m\Omega @ V_{GS}=10V$
- $I_D=6A, R_{DS(ON)}=148m\Omega @ V_{GS}=4.5V$
- Super high density cell design for extremely low  $R_{DS(ON)}$
- DFN3X3-8L package design

## Pin Description ( DFN3X3-8L )



## Application

- DC/DC Converter
- Load Switch
- Power Management in Notebook Computer

## Pin Define

Pin	Symbol	Description
1	S	Source
2	S	Source
3	S	Source
4	G	Gate
5	D	Drain
6	D	Drain
7	D	Drain
8	D	Drain

## Ordering Information

Part Ordering No.	Part Marking	Package	Unit	Quantity
AFN3316WFN338RG	AFN3316W YYMMDD	DFN3X3-8L	Tape & Reel	5000 EA

※ YY year code

※ MM month code

※ DD date code

※ AFN3316WFN338RG : 13" Tape & Reel ; Pb-Free ; Halogen-Free



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### Absolute Maximum Ratings

( $T_A=25^\circ\text{C}$  Unless otherwise noted)

Parameter	Symbol	Value		Unit	
Drain-Source Voltage	$V_{DSS}$	60		V	
Gate -Source Voltage	$V_{GSS}$	$\pm 20$		V	
Continuous Drain Current( $T_J=150^\circ\text{C}$ )	$I_D$	8	A		
		6			
Pulsed Drain Current	$I_{DM}$	10		A	
Continuous Source Current(Diode Conduction)	$I_S$	1.6		A	
Power Dissipation	$P_D$	28	15	W	
		3.2	2.0		
Operating Junction Temperature	$T_J$	150		$^\circ\text{C}$	
Storage Temperature Range	$T_{STG}$	-55/150		$^\circ\text{C}$	
Thermal Resistance Junction-to-Case (Drain)	$R_{\theta JC}$	5		$^\circ\text{C}/\text{W}$	
Thermal Resistance-Junction to Ambient	$R_{\theta JA}$	40			

### Electrical Characteristics

( $T_A=25^\circ\text{C}$  Unless otherwise noted)

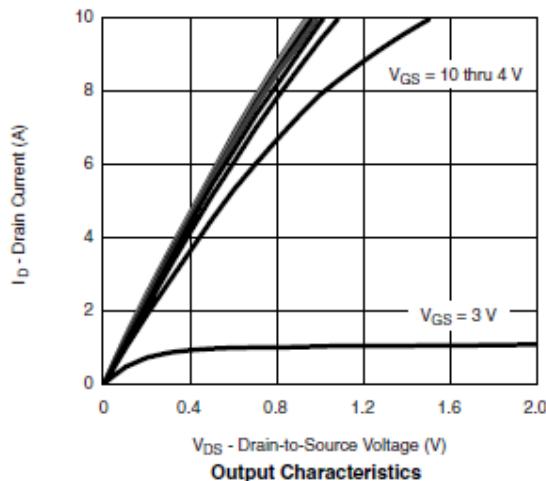
Parameter	Symbol	Conditions	Min.	Typ	Max.	Unit
<b>Static</b>						
Drain-Source Breakdown Voltage	$V_{(BR)DSS}$	$V_{GS}=0\text{V}, I_D=250\mu\text{A}$	60			V
Gate Threshold Voltage	$V_{GS(\text{th})}$	$V_{DS}=V_{GS}, I_D=250\mu\text{A}$	0.7		2.5	
Gate Leakage Current	$I_{GSS}$	$V_{DS}=0\text{V}, V_{GS}=\pm 20\text{V}$			$\pm 100$	$\text{nA}$
Zero Gate Voltage Drain Current	$I_{DSS}$	$V_{DS}=60\text{V}, V_{GS}=0\text{V}$			1	$\text{uA}$
		$V_{DS}=60\text{V}, V_{GS}=0\text{V}$ $T_J=85^\circ\text{C}$			10	
On-State Drain Current	$I_{D(\text{on})}$	$V_{DS} \geq 5\text{V}, V_{GS}=10\text{V}$	10			A
Drain-Source On-Resistance	$R_{DS(\text{on})}$	$V_{GS}=10\text{V}, I_D=8\text{A}$		128	140	$\text{m}\Omega$
		$V_{GS}=4.5\text{V}, I_D=6\text{A}$		136	148	
Forward Transconductance	$g_{FS}$	$V_{DS}=15\text{V}, I_D=2.0\text{A}$		12		S
Diode Forward Voltage	$V_{SD}$	$I_S=2.0\text{A}, V_{GS}=0\text{V}$		0.85	1.2	V
<b>Dynamic</b>						
Total Gate Charge	$Q_g$	$V_{DS}=30\text{V}, V_{GS}=10\text{V}$ $I_D=3\text{A}$		6	15	$\text{nC}$
Gate-Source Charge	$Q_{gs}$			1.5		
Gate-Drain Charge	$Q_{gd}$			2.0		
Input Capacitance	$C_{iss}$	$V_{DS}=35\text{V}, V_{GS}=0\text{V}$ $f=1\text{MHz}$		350		$\text{pF}$
Output Capacitance	$C_{oss}$			30		
Reverse Transfer Capacitance	$C_{rss}$			20		
Turn-On Time	$t_{d(\text{on})}$	$V_{DD}=30\text{V}, R_L=10\Omega$ $I_D=5.0\text{A}, V_{GEN}=10\text{V}$		6	12	$\text{ns}$
	$t_r$			6	12	
Turn-Off Time	$t_{d(\text{off})}$			12	20	
	$t_f$			4	10	



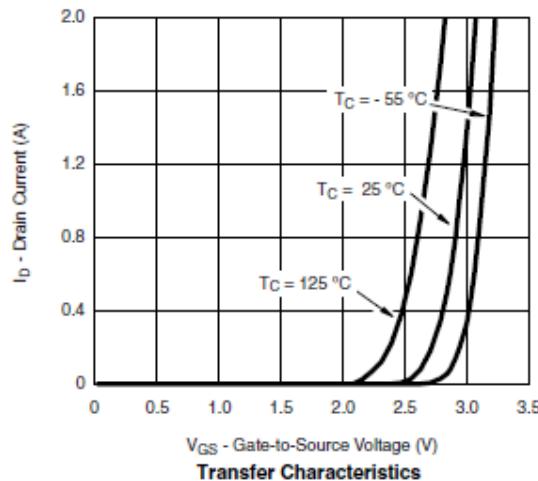
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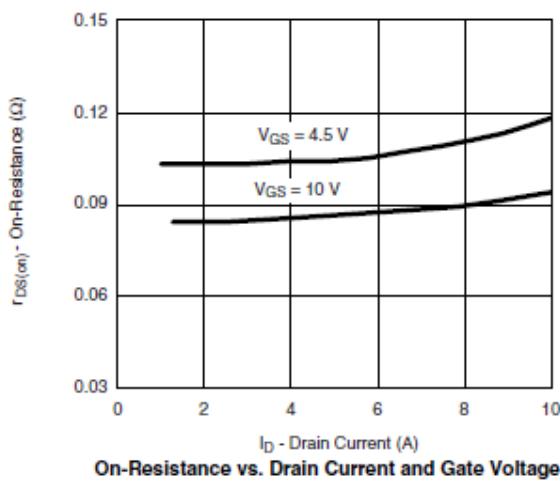
## Typical Characteristics



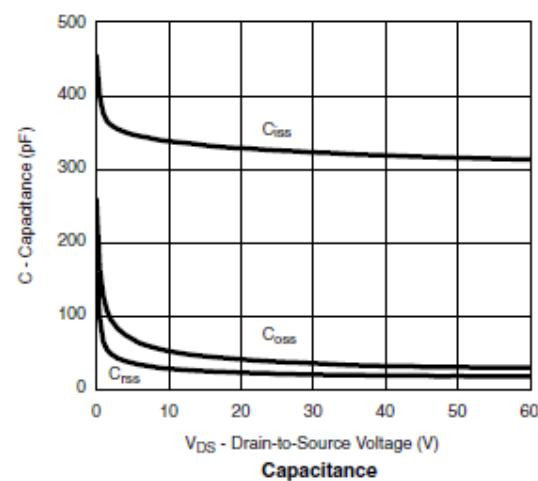
$V_{DS}$  - Drain-to-Source Voltage (V)  
Output Characteristics



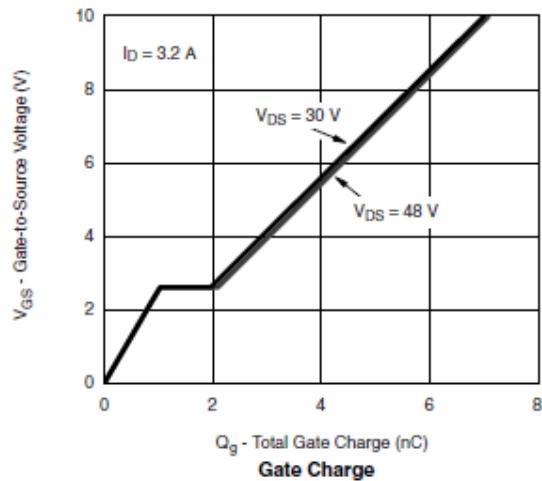
$T_C = -55^\circ\text{C}$   
 $T_C = 25^\circ\text{C}$   
 $T_C = 125^\circ\text{C}$   
Transfer Characteristics



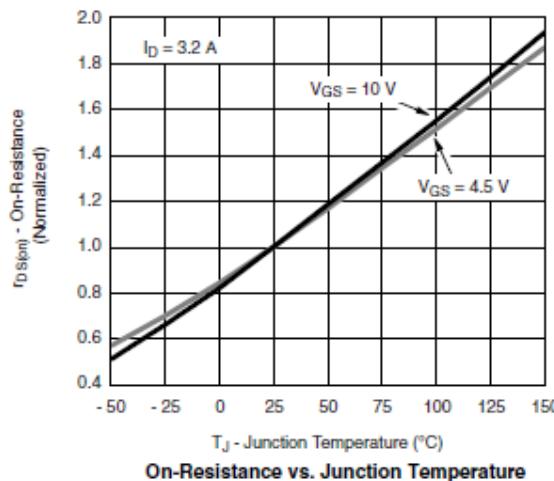
$I_D$  - Drain Current (A)  
On-Resistance vs. Drain Current and Gate Voltage



$C_{iss}$   
 $C_{oss}$   
 $C_{rss}$   
Capacitance



$I_D = 3.2\text{ A}$   
 $V_{DS} = 30\text{ V}$   
 $V_{DS} = 48\text{ V}$   
Gate Charge



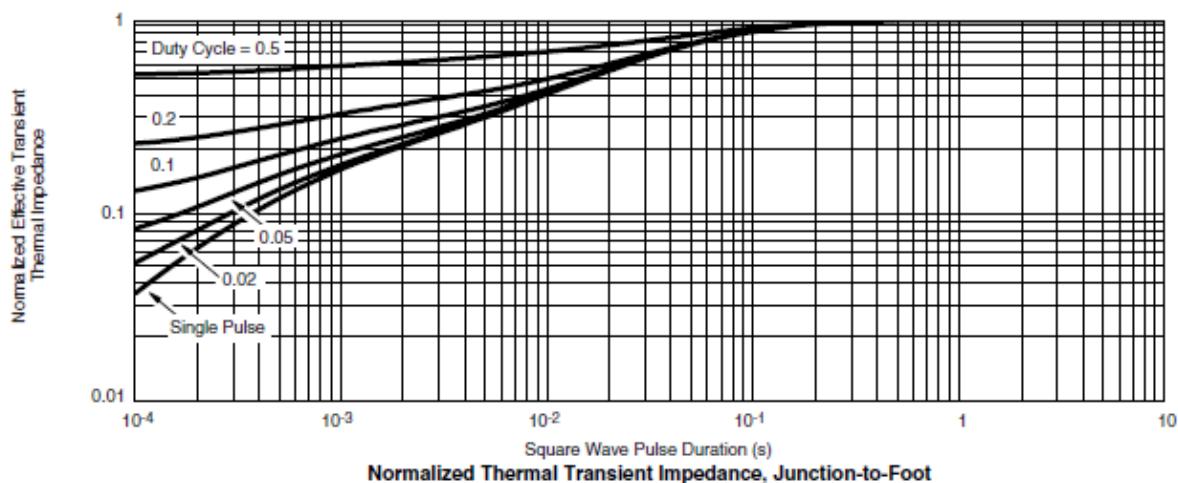
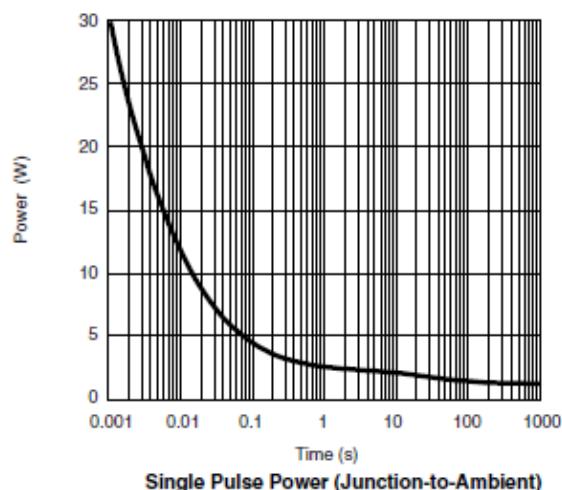
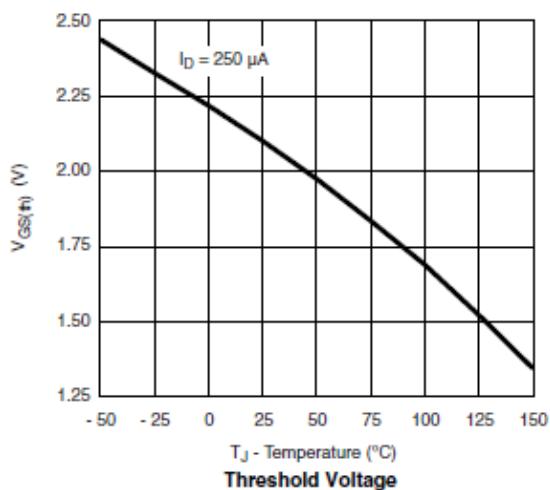
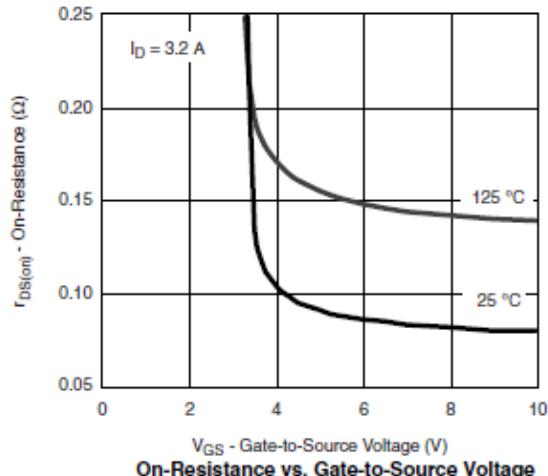
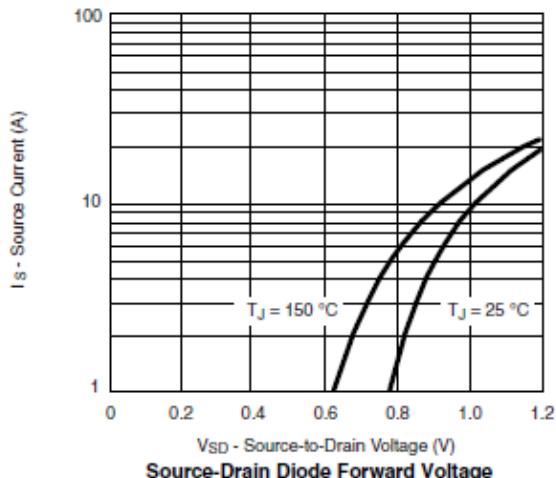
$I_D = 3.2\text{ A}$   
 $V_{GS} = 10\text{ V}$   
 $V_{GS} = 4.5\text{ V}$   
On-Resistance vs. Junction Temperature



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### Typical Characteristics



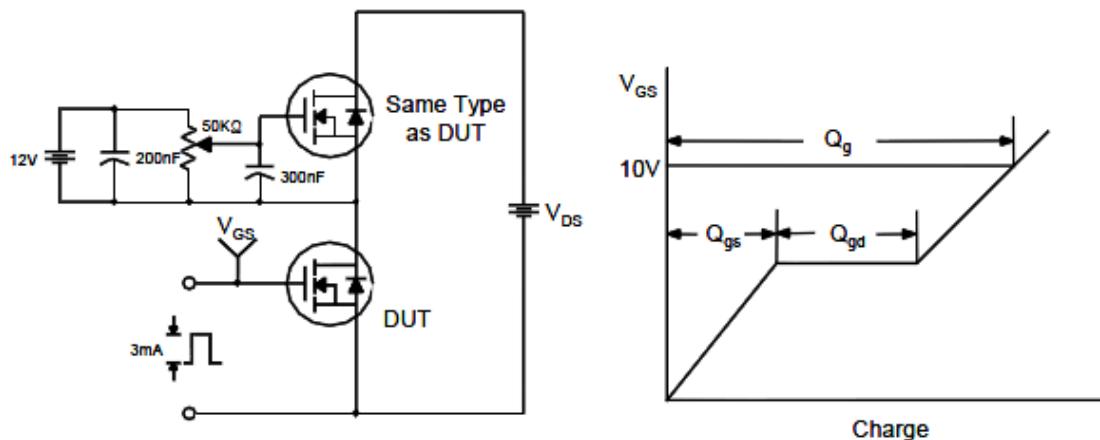


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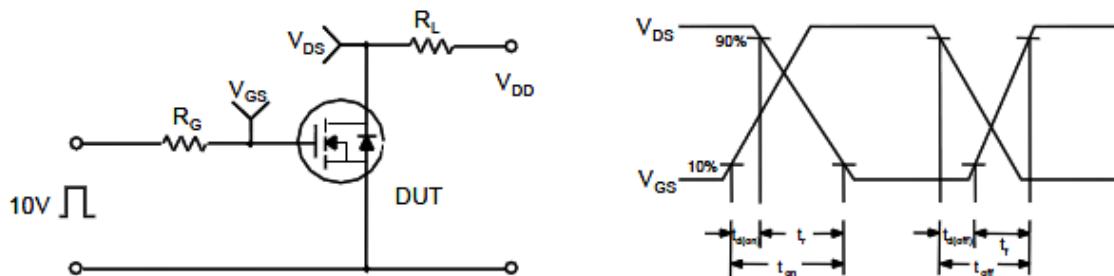
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## Typical Characteristics

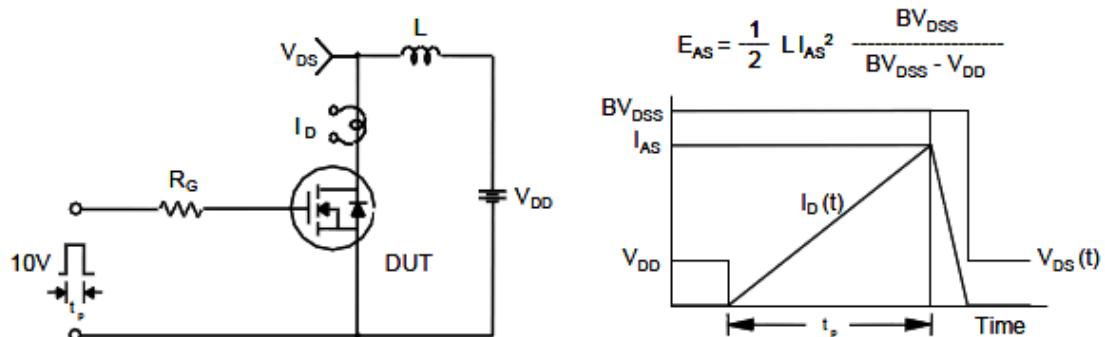
Gate Charge Test Circuit & Waveform



Resistive Switching Test Circuit & Waveforms



Unclamped Inductive Switching Test Circuit & Waveforms

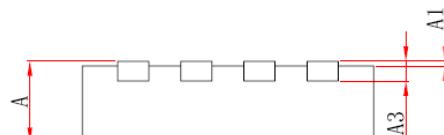
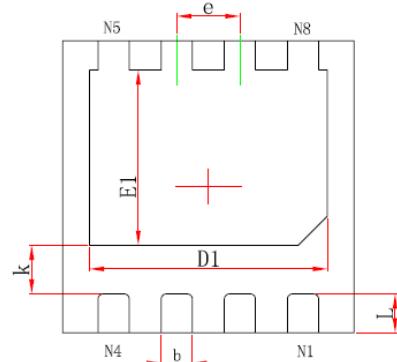
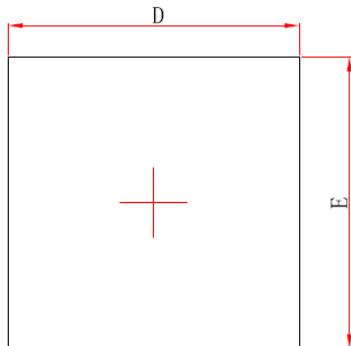




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**Package Information ( DFN3X3-8L )**



**Top View**

**Bottom View**

**Side View**

Symbol	Dimensions In Millimeters		Dimensions In Inches	
	Min.	Max.	Min.	Max.
A	0.800	0.900	0.031	0.035
A1	0.000	0.050	0.000	0.002
A3	0.203REF.		0.008REF.	
D	2.924	3.076	0.115	0.121
E	2.924	3.076	0.115	0.121
D1	2.350	2.550	0.093	0.100
E1	1.700	1.900	0.067	0.075
k	0.450	0.550	0.018	0.022
b	0.270	0.370	0.011	0.015
e	0.650TYP.		0.026TYP.	
L	0.324	0.476	0.013	0.019

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